- Designed for TIA/EIA-485, TIA/EIA-422, and ISO 8482 Applications
- Signaling Rate[†] Exceeding 50 Mbps
- Fail-Safe in Bus Short-Circuit, Open-Circuit, and Idle-Bus Conditions
- ESD Protection on Bus Inputs Exceeds 6 kV
- Common-Mode Bus Input Range -7 V to 12 V
- Propagation Delay Times <16 ns
- Low Standby Power Consumption <20 μA
- Pin-Compatible Upgrade for AM26LS32, DS96F173, LTC488, and SN75173

description

The SN65LBC173A and SN75LBC173A are quadruple differential line receivers with 3-state outputs, designed for TIA/EIA-485 (RS-485), TIA/EIA-422 (RS-422), and ISO 8482 (Euro RS-485) applications.

These devices are optimized for balanced multipoint bus communication at data rates up to and exceeding 50 million bits per second. The transmission media may be twisted-pair cables, printed-circuit board traces, or backplanes. The ultimate rate and distance of data transfer is dependent upon the attenuation characteristics of the media and the noise coupling to the environment.

SN65LBC173A (Marked as 65LBC173A) SN75LBC173A (Marked as 75LBC173A) D or N PACKAGE (TOP VIEW)							
1B [1A [1Y [2Y [2A [1 2 3 4 5 6	16 15 14 13 12 11	V _{CC} 4B 4A 4Y G 3Y				
2B [GND [7 8	10 9	3A 3B				

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logic diagram



Each receiver operates over a wide range of positive and negative common-mode input voltages, and features ESD protection to 6 kV, making it suitable for high-speed multipoint data transmission applications in harsh environments. These devices are designed using LinBiCMOS[™], facilitating low power consumption and robustness.

The G and \overline{G} inputs provide enable control logic for either positive- or negative-logic enabling all four drivers. When disabled or powered off, the receiver inputs present a high-impedance to the bus for reduced system loading.

The SN75LBC173A is characterized for operation over the temperature range of 0°C to 70°C. The SN65LBC173A is characterized over the temperature range from –40°C to 85°C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

LinBiCMOS is a trademark of Texas Instruments.

[†]The signaling rate of a line is the number of voltage transitions that are made per second expressed in the units bps (bits per second).

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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FUNCTION TABLE (each receiver)						
DIFFERENTIAL INPUTS	OUTPUT					
A – B (V _{ID})	G	G	Y			
	Н	Х				
VID ≤ -0.2 V	Х	L	L			
	Н	Х	0			
–0.2 V < V _{ID} < –0.01 V	Х	L	?			
0.04.1/ 41/	Н	Х				
-0.01 V ≤ VID	Х	L	н			
X	L	Н	7			
X	OPEN	OPEN	Z			
Oh and almost	Н	Х				
Snort circuit	Х	L	Н			
Open circuit	Н	Х	Н			

H = high level, L = low level, X = irrelevant, Z = high impedance (off), ? = indeterminate

AVAILABLE OF HONS						
	PACKAGE					
T _A	PLASTIC SMALL OUTLINE [†] (JEDEC MS-012)	PLASTIC DUAL-IN-LINE (JEDEC MS-001)				
0°C to 70°C	SN75LBC173AD	SN75LBC173AN				
-40°C to 85°C	SN65LBC173AD	SN65LBC173AN				

AVAILABLE OPTIONS

[†]Add an R suffix for taped and reeled

equivalent input and output schematic diagrams



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absolute maximum ratings[†]

Supply voltage range, V_{CC} (see Note 1) Voltage range at any bus input (DC) Voltage range at any bus input (transient p Voltage input range at G and \overline{G} , V_1	oulse through 100 Ω , see Figu	0.3 V to 6 V 10 V to 15 V re 5)
Electrostatic discharge:		
Human body model (see Note 2):	A and B to GND	6 kV
	All pins	5 kV
Charged-device model (see Note 3):	All pins	
Storage temperature range	· · · · · · · · · · · · · · · · · · ·	
Continuous power dissipation		See Power Dissipation Rating Table
Lead temperature 1,6 mm (1/16 inch) from	case for 10 seconds	Ž260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values, except differential I/O bus voltages, are with respect to GND, and are steady-state (unless otherwise specified).

- 2. Tested in accordance with JEDEC Standard 22, Test Method A114-A.
- 3. Tested in accordance with JEDEC Standard 22, Test Method C101.

DISSIPATION RATING TABLE

PACKAGE	$T_A \le 25^{\circ}C$ POWER RATING	DERATING FACTOR [‡] ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
D	1080 mW	8.7 mW/°C	690 mW	560 mW
Ν	1150 mW	9.2 mW/°C	736 mW	598 mW
+ · · · · ·				

[‡] This is the inverse of the junction-to-ambient thermal resistance when board-mounted and with no air flow.

recommended operating conditions

		MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}		4.75	5	5.25	V
Voltage at any bus terminal	A, B	-7		12	V
High-level input voltage, VIH		2		VCC	N
Low-level input voltage, VIL	G, G			0.8	V
Output current	Y	-8		8	mA
On and the first statement of T	SN75LBC173A	0		70	
Operating free-air temperature, 1A	SN65LBC173A	-40		85	Ĵ



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electrical characteristics over recommended operating conditions

	PARAMETER	R	TEST CO	NDITIONS	MIN	TYP†	MAX	UNIT
VIT+	Positive-going differential inp	out voltage threshold	7.1/2/1/2/00/0			-80	-10	
VIT-	Negative-going differential ir	nput voltage threshold	$-7 V \le V_{CM} \le 12 V (V_{CM} \le 12 V)$	CM = (VA + VB)/2)	-200	-120		mv
VHYS	Hysteresis voltage (VIT+ - V	VIT–)				40		mV
VIK	Input clamp voltage		lj =18 mA		-1.5	-0.8		V
VOH	High-level output voltage		V _{ID} = 200 mV, I _{OH} = -8 mA		2.7	4.8		
VOL	Low-level output voltage		$V_{ID} = -200 \text{ mV},$ $I_{OL} = 8 \text{ mA}$	See Figure 1		0.2	0.4	V
I _{OZ}	High-impedance-state output	ut current	$V_{O} = 0 V \text{ to } V_{CC}$		-1		1	μΑ
	the fear of a second second		Other input at 0 V,	V _I = 12 V			0.9	
11	Line input current		$V_{CC} = 0 V \text{ or } 5 V$	$V_{I} = -7 V$	-0.7			mΑ
IIН	High-level input current						100	μΑ
۱ _{IL}	Low-level input current	Enable inputs G, G			-100			μΑ
RI	Input resistance	A, B inputs			12			kΩ
		$V_{ID} = 5 V$	G at 0 V, G at V _{CC}			20	μΑ	
'CC	Supply current		No load	G at V _{CC} , G at 0 V		11	16	mA

[†] All typical values are at $V_{CC} = 5 V$ and $25^{\circ}C$.

switching characteristics over recommended operating conditions

	PARAMETER	TEST CONDITIONS	MIN	түр†	MAX	UNIT
t _r	Output rise time			2	4	ns
t _f	Output fall time	$V_{ID} = -3 V$ to 3 V, See Figure 2		2	4	ns
^t PLH	Propagation delay time, low-to-high level output		9	12	16	ns
^t PHL	Propagation delay time, high-to-low level output		9	12	16	ns
^t PZH	Propagation delay time, high-impedance to high-level output			27	38	ns
^t PHZ	Propagation delay time, high-level to high-impedance output	See Figure 3		7	16	ns
t _{PZL}	Propagation delay time, high-impedance to low level output	Coo Figure 4		29	38	ns
^t PLZ	Propagation delay time, low-level to high-impedance output	See Figure 4		12	16	ns
t _{sk(p)}	Pulse skew ((tpLH – tpHL))			0.2	1	ns
tsk(o)	Output skew (see Note 4)				2	ns
tsk(pp)	Part-to-part skew (see Note 5)				2	ns

[†] All typical values are at $V_{CC} = 5 V$ and $25^{\circ}C$.

NOTES: 4. Outputs skew (t_{Sk(o)}) is the magnitude of the time delay difference between the outputs of a single device with all of the inputs connected together.

 Part-to-part skew (t_{sk(pp)}) is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same input signals, the same supply voltages, at the same temperature, and have identical packages and test circuits.



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PARAMETER MEASUREMENT INFORMATION



Figure 1. Voltage and Current Definitions



Generators: PRR = 1 MHz, 50% Duty Cycle, tr <6 ns, Z_0 = 50 Ω

Figure 2. Switching Test Circuit and Waveforms



Generators: PRR = 1 MHz, 50% Duty Cycle, t_{r} <6 ns, Z_{0} = 50 Ω





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PARAMETER MEASUREMENT INFORMATION

Generators: PRR = 1 MHz, 50% Duty Cycle, tr <6 ns, Zo = 50 Ω





Figure 5. Test Circuit and Waveform, Transient Over-Voltage Test



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TYPICAL CHARACTERISTICS





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TYPICAL CHARACTERISTICS

Figure 10. Receiver Inputs and Outputs, 50 Mbps Signaling Rate



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APPLICATION INFORMATION

Figure 11. Typical Application Circuit, DSP-to-DSP Link via Serial Peripheral Interface



Figure 12. Typical Application Circuit, High-Speed Servomotor Encoder Interface



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MECHANICAL DATA

PLASTIC SMALL-OUTLINE PACKAGE

D (R-PDSO-G**) 14 PINS SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-012



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MECHANICAL DATA

PLASTIC DUAL-IN-LINE PACKAGE

N (R-PDIP-T**)



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Falls within JEDEC MS-001 (20-pin package is shorter than MS-001).



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